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To cite this version:
Ville Liimatainen, Mohamed Kharboutly, David Rostoucher, Michaël Gauthier, Quan Zhou. Capillary self-alignment assisted hybrid robotic Handling for Ultra-Thin Die Stacking. IEEE International Conference on Robotics and Automation (ICRA), Jan 2013, Finland. pp.1395 - 1400, 2013. <hal-00833834>

HAL Id: hal-00833834
https://hal.archives-ouvertes.fr/hal-00833834
Submitted on 13 Jun 2013

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Capillary Self-Alignment Assisted Hybrid Robotic Handling for Ultra-Thin Die Stacking

Ville Liimatainen¹, Mohamed Kharboutly², David Rostoucher², Michaël Gauthier², Member, IEEE, and Quan Zhou¹, Member, IEEE.

Abstract—Ultra-thin dies are difficult to package because of their fragility and flexibility. Current ultra-thin die integration technology for 3D microsystems relies on robotic pick-and-place machines and machine vision, which has rather limited throughput for high-accuracy assembly of fragile ultra-thin dies. In this paper, we report a hybrid assembly strategy that consists of robotic pick-and-place using a vacuum micro-gripper, and droplet self-alignment by capillary force. Ultra-thin dies with breakable links are chosen as part of the assembly strategy. Experimental results show that we can align ultra-thin (10µm) dies with sub-micron accuracy without machine vision. A fully automatic sequence of stacking several of these dies is demonstrated. Up to 12 ultra-thin dies have been stacked. These early results show that die-to-die integration of ultra-thin dies with higher throughput than the current industry robot is possible by applying both robotic handling and droplet self-alignment to ultra-thin die assembly.

I. INTRODUCTION

Ultra-thin dies are thinned semiconductor chips having thickness below e.g. 20µm, which is an evolving value as the technology progresses. The primary need for ultra-thin die fabrication and assembly techniques is in 3D integration, where different active dies are vertically connected in stacks using through-silicon-vias (TSV). Ultra-thin dies offer several benefits for such die stacks. They enable lower package height for thin integrated circuits (IC) applications, enhanced heat flow for high power components, shorter interconnections for faster operation and easier TSV formation due to reduced thickness.

One great challenge in ultra-thin die stacking is to fulfill the requirement of high-accuracy and high-throughput simultaneously, while avoiding damage to the dies. For 3D die stacks, the alignment accuracy of TSVs between the dies is crucial to ensure working electrical connections. According to the ITRS roadmap for 3D die stacks, the required alignment accuracies are approaching the sub-micron level while the number of aligned layers is increasing beyond two [1]. Currently tools such as flip-chip die bonder are used for stacking thin dies using machine vision based positioning technology. In addition to accuracy, which translates to yield, fast assembly is essential for cost-effectiveness. Current state-of-the-art die bonding machines can achieve very high throughput when the positioning accuracy is modest, but when the accuracy requirement increases, the throughput decreases. For example, sub-micron accuracy in the assembly of thick dies is achievable on commercial systems, but with very low throughput of only a couple of hundred dies per hour [2]. For ultra-thin dies the throughput is further limited due to fragility and flexibility of the dies.

To tackle the throughput and accuracy dilemma, we use an assembly method for ultra-thin dies based on capillary self-alignment assisted robotic pick-and-place. The method is built upon the recent efforts on combining robotic micro-handling and self-assembly into a hybrid microassembly strategy [3-7], where fast-speed robotic pick-and-place is used for coarse positioning, and high accuracy is reached by capillary self-alignment of a droplet, driven by the capillary force between the die and the receptor site. The capillary force also aids in overcoming the adhesion forces between the die and the gripper, which is a common problem in micromanipulation. Despite previous studies has been carried out on hybrid microassembly, the ultra-thin die stacking brings many new challenges to be tackled, including the handling of fragile dies, the potential effect of such dies on self-alignment, and the question if the required accuracy can be achieved for ultra-thin dies.

To avoid damaging the fragile dies during handling, the ultra-thin dies are prepared in a silicon layer with breakable links, similar to [8]. Since this study is the first step in investigation of this method, only dummy dies are used. Vacuum tools and precision robotic positioning system is used for pick-and-place of the dies. To achieve good alignment in die stacking, we investigated several water droplet self-alignment approaches. And finally, we have stacked up to 12 ultra-thin dies to demonstrate the feasibility of the approach.

II. ULTRA-THIN DIES WITH BREAKABLE LINKS

To fabricate ultra-thin dies, the wafer must be thinned. Conventionally, thinning of wafers is done by grinding the back side of the wafer [9]. This mechanical grinding can be combined with polishing like in the traditional chemical-mechanical-polishing method (CMP), or the surface can be finished after grinding by wet etching or dry plasma etching. The dies are then singulated by sawing on a thermal or UV sensitive dicing tape, or by DRIE etching on a carrier wafer. More recently, the process has been altered so that dicing happens as a result of grinding the wafer backside until pre-cut grooves on the front side are reached. Plasma etching is then normally used for finishing the ground surface and for stress relief of the dies.

The challenge with the thinning and singulation processes is that they damage the dies in several ways [10]. The situation gets worse when the dies become thinner, and the...
problem extends to picking them up intact from a temporary carrier tape or wafer. Indeed, in the case of a die with thickness around 10µm, the force required to remove it from adhesive tape may be higher than the mechanical rupture force of the die. To bypass these problems, we fabricate the dies on the device layer of an SOI wafer by etching around the dies, leaving them connected to the background only at one point, using a technique similar to [11]. This connection serves as a breakable link, as presented in Fig. 1.

The dies are fabricated in three main steps (Fig. 2). First, the handle layer (typically 400 µm thick) of an SOI wafer is etched through until the silicon dioxide insulator layer by deep reactive-ion etching (DRIE), as shown in Fig. 2 (Step 1). Then the device layer is patterned and etched in the shape of the dies, leaving narrow bridges to connect the dies to the background (Fig. 2, Step 2). Finally, the intermediate silicon dioxide layer is removed using hydrogen-fluoride (HF) vapor and the dies are left hanging on the breakable links (Fig 2, Step 3). The structure and dimensions of the links (Fig.1, highlighted in red) have been designed so that the rupture during cracking is confined and does not damage the die, as explained in the next section.

III. METHODS AND TOOLS

The die and breakable link structure must respect three main mechanical constraints. First, it should be strong enough to survive the fabrication process. Second, the link should break when the die is pushed vertically down by a vacuum gripper head. Third, the die should withstand the suction force applied by the vacuum gripper during pick-and-place operation. These constraints, summarized in Fig. 3, were determined by estimation, simulation and measurements. The same constraints were also considered in the design of a suitable vacuum gripper and handling strategy.

A. Mechanical characterization of breakable links

Several types of breakable link structures were designed and fabricated for a fixed die area of 1 mm² while both 10µm and 5µm thicknesses were tested. Strength of the link designs were both simulated (Comsol Multiphysics 3.5) and measured. The fabrication process and especially wet etching induced significant forces which could break the link. The process (Fig. 2) was tested on a test wafer with a large variety of links. We observed that the links whose simulated breaking force is lower than 0.3mN could be broken during the fabrication process. Consequently, we assume that the fabrication process is able to apply a maximal force of 0.3 mN. In order to measure the breaking force, a normal force was applied with a force sensor (Femto-Tools FT-S 1000) in the center area of the die (Fig. 4). For the breakable link shown in Fig. 1, simulation predicted a rupture force of 1mN, which was in good agreement with the average measured rupture force of 1.5 mN. Fig. 5 shows a broken link after pick-up from the wafer, with the rupture safely confined outside of the die.
Figure 4. Measurement of breakable link strength by applying normal force with a force sensor in the die center.

Figure 5. Detached die with a broken link after pick-up from the wafer.

As shown in Fig. 3, the gripper should be able to handle dies with a force lower than the rupture force of the dies, which has been simulated by finite element method to reach 250 mN (Comsol Multiphysics 3.5). To ensure such a low handling force, a vacuum gripper with controllable suction force was developed.

### B. Handling of ultra-thin dies

The working principle of the developed vacuum gripper is presented in Fig. 6. Air is pumped from the gripper head when an electro-valve between the gripper and the pump is open. There is also a leak hole in the gripper head, which allows suction force on the die to be controlled. Gripper heads with different leak hole sizes were designed. The suction pressure can be as low as 10 kPa, ensuring safe handling of the dies.

Pick-and-place of the dies is performed using a robotic micro-assembly station shown in Fig. 7. The system consists of an x-axis positioning stage (Physik Instrumente M-404.8PD, 0.25 μm accuracy), a y-axis positioning stage (Physik Instrumente M-122.2DD, 0.1 μm accuracy), a vertical positioning stage where the vacuum gripper is mounted (Physik Instrumente M-122.2DD, 0.1 μm accuracy), a water dispenser (Gesim PicPIP) and microscopes for top, side and angled views. The top view microscope (Edmund Optics VZM1000i) is attached to a high-speed CCD video camera (Imperx IGV-B1620M). There is also a microscope (Edmund Optics VZM600i) providing angled view, attached to a progressive scan camera (Sony XC-8500). Droplet dispensing is done at one end of the station (Fig. 7, back) assisted by the top view, and pick-and-place at the other end (Fig. 7, front).

IV. EXPERIMENTAL

In order to experimentally validate feasibility of the hybrid handling approach (sketched in Fig. 8) for stacking of ultra-thin dies, tests with different process parameters were performed. The basic procedure is as follows: an ultra-thin die is picked up by the gripper (Fig. 9), water droplet(s) are dispensed on the die at the top of the stack, the picked die is released above the stack and capillary force aligns the die with the die on top of the stack (Fig. 10). The desired accurate self-alignment is defined as no visible alignment error with respect to the other dies of the die stack in optical microscope images (sub-micron accuracy). The optically determined accuracy was also verified in SEM for the large die stacks (12 dies).

Two different aspects of this procedure were studied: 1) the parameters related to the droplets on the top of a die stack, including the number of droplets, the volume of the droplets, and the distribution of the droplets; 2) the effect of biases in the die releasing position and orientation.
Figure 8. Concept of hybrid microassembly: a) receptor site, e.g. a die, b) liquid, e.g. water, is dispensed on the receptor site, c) a pick-and-place tool such as a vacuum gripper brings a picked die on top of the receptor site, d) the picked die is released on top of the receptor site and a water meniscus is formed between the parts, e) capillary forces of the water droplet minimize potential energy of the droplet, self-aligning the top die on the receptor site, and f) water evaporates and the parts are left in contact.

Figure 9. Die detachment from the wafer: (a) approach, (b) breaking the link by pushing, and (c) grasping the die by suction.

A. Water droplet influences

The influence of the number of water droplets, the volume of droplets and droplet distribution has been studied against the final position of the released dies, i.e. accuracy of the alignment, and the duration of the self-alignment process. To avoid influences from other parameters, the dies were released directly on the top of the stack without intentional bias. For the droplet influence tests, three cases were studied.

In the first case, one small droplet was dispensed in the center of the die, covering about 25% of its surface (Fig. 11(a)), with an estimated volume of 7 nl. After the die was placed on top of the droplet, the droplet spread due to wetting. However, such wetting process stops at the cavity of the breakable link structure (Fig. 11(a)) due to the edge pinning the water [12]. Consequently, such wetting leads to an asymmetric total wetted surface relative to the geometrical center of the die at the top of the stack, and clear misalignment can be observed consistently (Fig. 11(b)).

In the second case, a larger droplet (estimated volume 54 nl) was dispensed in the center, which covers more than 80% of the die surface, including the breakable link structures. The droplet is confined only by the edges of the stack top die (Fig. 11(c)) and the water completely bridges the cavity of the breakable link. Therefore, self-alignment was governed by the edges of the die under the droplet and was accurate (Fig. 11(d)). However, evaporation of the water droplet takes a longer time with increased volume (e.g. 90 seconds for the droplet in Fig. 10). Therefore, using a large droplet is suboptimal regarding process throughput.

In the third case, we dispensed four small droplets near the corners of the die, each covering about 10% of the surface area and having a volume of approximately 3 nl, see Fig. 11(e). Due to the position of the droplets, the cavity of the breakable link does not hinder wetting when a die is placed on top of the droplets. Therefore the droplet will wet the whole die area during self-alignment and the alignment is accurate as expected (Fig. 11(f)). Furthermore, water evaporation time with the four-droplet configuration is significantly reduced to approximately one second, giving a clear advantage over the single-droplet case.

B. Release position and angular biases

The second part of the experiments studies the effect of biases in the release position on the alignment accuracy. The independently studied parameters are: x- and y-bias, z-bias (release height) and angular bias θ (die rotation). These parameters are illustrated in Fig. 12.
Based on earlier extensive results on hybrid microassembly [5], droplet-based self-alignment of microchips is almost a binary process—a parameter set for successful self-alignment will very reliably lead to success every time, and vice versa. Therefore, a well-planned single test gives a good indication of whether self-alignment will work or not. In the experiments, the four-droplet approach was chosen as dispensing strategy due to its advantage in alignment speed, as discussed above.

1) **Effect of x- and y- bias:** As the die outline is symmetric with respect to the x- and y-axes, only x-direction was considered in these tests. Release height (z) was fixed at 50µm and the angular bias θ was kept as close to zero as possible. The tests showed that for the 1mm×1mm dies self-alignment was accurate up to a 900µm bias in the x-direction (Fig. 13, top row). Beyond that limit, top of die to be placed was wetted as well and self-alignment failed (Fig. 13, bottom row). The biases tested were 620µm, 720µm, 770µm, 900µm and 950µm.

2) **Effect of z-bias:** Influence of release height on self-alignment was tested by varying it along the z-direction with no other biases present. Tests with the release height ranging from 0.4mm to 1.25mm showed that alignment was successful up to a distance of 1mm from the stack top die surface (Fig. 14, top row). With larger release heights the die may fall too far from the receiving die for self-alignment to work (Fig. 14, bottom row). The biases tested were 0.4mm, 0.7mm, 0.9mm, 1mm and 1.25mm.

3) **Effect of angular bias:** Angular bias θ was applied with values of 0, 30 and 40 degrees. At 45 degrees there is a local maximum of potential energy due to symmetry.

Release height was fixed at 50µm and there was no other bias. Alignment was accurate in all the tests, showing that rotation of the die alone does not impede self-alignment.

Further tests were performed by combining lateral biases with angular bias, within the limits of each bias obtained earlier. Alignment succeeded accurately in all the tests. This confirms that capillary self-alignment is a feasible method for accurate stacking of 10µm thick dies. Relatively large inaccuracies can be allowed in the initial release position without affecting the final alignment accuracy.

V. MICRO-ASSEMBLY OF ULTRA-THIN DIES

The experiments described so far have been done one by one with teleoperation control of the positioning systems, dispenser and vacuum gripper. In this section, automatic stacking of 3 dies and semi-automatic stacking of up to 12 ultra-thin dies are reported.

Automation of the ultra-thin die stacking was done to demonstrate the relevance to real-world applications. The procedure is rather straightforward. As the dies are located on the wafer with regular spacing, they can be easily picked and stacked sequentially by incrementing the picking position coordinates after each release. The release position can be maintained fixed or incremented as needed for different stack heights. A stack of 3 ultra-thin dies was assembled using this method. Stacking more dies automatically will be straightforward. However, it has not been done because the dispenser is not installed on a motorized stage in the current setup. In the tests, only one large droplet was dispensed in each cycle, and the result shows that the droplet from previous cycle need not be evaporated for the self-alignment of the next die to work. The automatic stacking of 3 dies took about 40 seconds, due to long-range transportation with low-speed positioning stages between the dispensing and vacuum gripping units of the hybrid assembly station (Fig. 7). The process can be improved by using a state-of-the-art pick-and-place machine, and the resulting throughput can be expected to be better than assembly without self-alignment, because no
time-consuming machine vision based fine positioning is needed.

The stacking of larger number of dies has also been done using teleoperation. Firstly, stacks of two dies were grasped and self-aligned on top of each other to form stacks of 4 dies. The adhesion force between two stacked dies due to the capillary force that also aligned them, allows the handling of those 2-die stacks as one unit. The stacks of 4 dies were then assembled similarly to form a stack of 8 dies (Fig. 15), and finally 12 dies. An SEM image of the stack of 12 dies shows high accuracy of the assembly (Fig. 16).

VI. CONCLUSION

We have proposed a handling and assembly strategy for ultra-thin 10µm dies, which is clearly beyond the thickness found in state-of-the-art microassembly. The dies are built with breakable links, allowing safe pick-up without damage to the dies directly from the wafer instead of an intermediate carrier tape. A vacuum gripper with controllable suction force was developed for the pick-and-place task. Accurate stacking of the dies is based on capillary self-alignment of a water droplet. Experimental results show sub-micron alignment accuracy, proving the feasibility of the hybrid assembly strategy for the assembly of ultra-thin dies. However, we note that the achievable alignment accuracy is dependent on the die fabrication accuracy, and contamination from environment may have an impact on contact line of the self-alignment liquid [13], possibly affecting the alignment accuracy. Nevertheless, the approach has been shown to be very robust to placement inaccuracies of up to 90% of the die size. A fully automatic assembly process of several dies has also been demonstrated.

The dies used in this work were plain silicon without any functionality. Future research on the topic will include dies with micro-bumps, which is the case in real-world 3D integration of die stacks. It is expected that capillary self-alignment will also work for functional dies with bumps as long as the droplet is confined by the die edges and not by some other features on the die. Chemical functionalization of certain areas may be a solution in the latter case.

ACKNOWLEDGMENT

The authors would like to thank all the contributors in this collaborative work under the European project FAB2ASM (contract FoF-NMP-2010-260079): Efficient and Precise 3D Integration of Heterogeneous Microsystems from Fabrication to Assembly, (http://fab2asm.eu/).

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